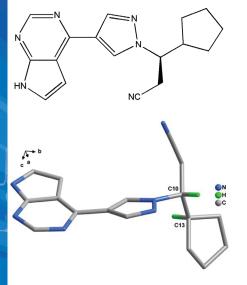
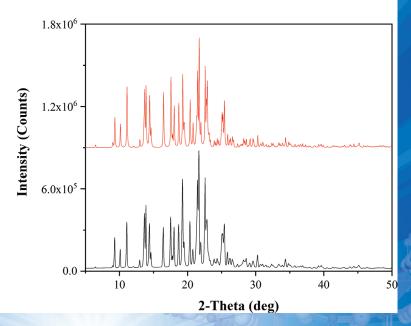
Powder Diffraction PDJ Journal of Materials Characterization

Molecular Diagram, Configuration and Observed (black) and Calculated (red) PXRD Patterns for Ruxolitinib, C₁₇H₁₈N₆





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The International Centre for Diffraction Data (ICDD®) is a non-profit scientific organization dedicated to collecting, editing, publishing, and distributing powder diffraction data for the identification of materials. The membership of the ICDD consists of worldwide representation from academe, government, and industry.

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On the Cover: The cover figures are from the manuscript "Crystal structure and X-ray powder diffraction data for ruxolitinib" by Chunguang Dai, Yuanjiang Pan and Xiurong Hu published in this issue. Ruxolitinib is a pharmaceutical used as an oral inhibitor for JAK1 and JAK2 and which is approved for the treatment of intermediate- and high-risk myelofibrosis (MF) and high-risk polycythemia vera (PV).







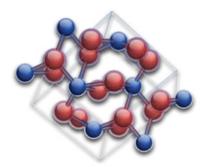
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ICDD 07/20

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